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With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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## FEATURES

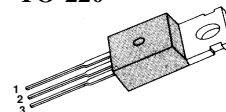
- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : -10  $\mu$ A (Max.) @  $V_{DS} = -200V$
- Low  $R_{DS(ON)}$  : 0.581  $\Omega$  (Typ.)

$$BV_{DSS} = -200 V$$

$$R_{DS(on)} = 0.8 \Omega$$

$$I_D = -6.5 A$$

TO-220



1. Gate 2. Drain 3. Source

## Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
$V_{DSS}$	Drain-to-Source Voltage	-200	V
$I_D$	Continuous Drain Current ( $T_C=25^\circ C$ )	-6.5	A
	Continuous Drain Current ( $T_C=100^\circ C$ )	-4.0	
$I_{DM}$	Drain Current-Pulsed ①	-26	A
$V_{GS}$	Gate-to-Source Voltage	+ 30	V
$E_{AS}$	Single Pulsed Avalanche Energy ②	563	mJ
$I_{AR}$	Avalanche Current ①	-6.5	A
$E_{AR}$	Repetitive Avalanche Energy ①	7.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.0	V/ns
$P_D$	Total Power Dissipation ( $T_C=25^\circ C$ )	70	W
	Linear Derating Factor	0.56	W/ $^\circ C$
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	- 55 to +150	$^\circ C$
$T_L$	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

## Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	1.79	$^\circ C/W$
$R_{\theta CS}$	Case-to-Sink	0.5	--	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

**Electrical Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$BV_{DSS}$	Drain-Source Breakdown Voltage	-200	--	--	V	$V_{GS}=0V, I_D=-250\mu A$
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	-0.17	--	$V/^\circ\text{C}$	$I_D=-250\mu A$ <b>See Fig 7</b>
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	--	-4.0	V	$V_{DS}=-5V, I_D=-250\mu A$
$I_{GSS}$	Gate-Source Leakage, Forward	--	--	-100	nA	$V_{GS}=-30V$
	Gate-Source Leakage, Reverse	--	--	100		$V_{GS}=30V$
$I_{DSS}$	Drain-to-Source Leakage Current	--	--	-10	$\mu A$	$V_{DS}=-200V$
		--	--	-100		$V_{DS}=-160V, T_C=125^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-State Resistance	--	--	0.8	$\Omega$	$V_{GS}=-10V, I_D=-3.3A$ ④
$g_{fs}$	Forward Transconductance	--	4.2	--	$\Omega$	$V_{DS}=-40V, I_D=-3.3A$ ④
$C_{iss}$	Input Capacitance	--	740	965	pF	$V_{GS}=0V, V_{DS}=-25V, f=1\text{MHz}$ <b>See Fig 5</b>
$C_{oss}$	Output Capacitance	--	125	185		
$C_{rss}$	Reverse Transfer Capacitance	--	49	75		
$t_{d(on)}$	Turn-On Delay Time	--	14	35	ns	$V_{DD}=-100V, I_D=-6.5A,$ $R_G=12\Omega$ <b>See Fig 13</b> ④ ⑤
$t_r$	Rise Time	--	22	55		
$t_{d(off)}$	Turn-Off Delay Time	--	41	90		
$t_f$	Fall Time	--	17	45		
$Q_g$	Total Gate Charge	--	29	36	nC	$V_{DS}=-160V, V_{GS}=-10V,$ $I_D=-6.5A$ <b>See Fig 6 &amp; Fig 12</b> ④ ⑤
$Q_{gs}$	Gate-Source Charge	--	5.8	--		
$Q_{gd}$	Gate-Drain( " Miller " ) Charge	--	13.6	--		

**Source-Drain Diode Ratings and Characteristics**

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$I_S$	Continuous Source Current	--	--	-6.5	A	Integral reverse pn-diode in the MOSFET
$I_{SM}$	Pulsed-Source Current ①	--	--	-26		
$V_{SD}$	Diode Forward Voltage ④	--	--	-5.0	V	$T_J=25^\circ\text{C}, I_S=-6.5A, V_{GS}=0V$
$t_{rr}$	Reverse Recovery Time	--	160	--	ns	$T_J=25^\circ\text{C}, I_F=-6.5A$
$Q_{rr}$	Reverse Recovery Charge	--	0.96	--	$\mu C$	$di_F/dt=100A/\mu s$ ④

**Notes ;**

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature  
 ②  $L=20\text{mH}, I_{AS}=-6.5A, V_{DD}=-50V, R_G=27\Omega^*,$  Starting  $T_J=25^\circ\text{C}$   
 ③  $I_{SD} \leq 6.5A, di/dt \leq 400A/\mu s, V_{DD} \leq BV_{DSS},$  Starting  $T_J=25^\circ\text{C}$   
 ④ Pulse Test : Pulse Width = 250  $\mu s$ , Duty Cycle  $\leq 2\%$   
 ⑤ Essentially Independent of Operating Temperature

Fig 1. Output Characteristics

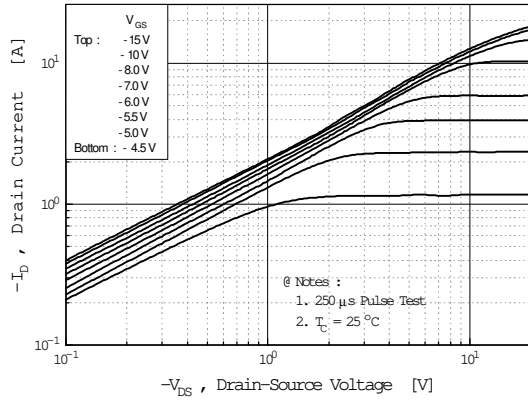


Fig 2. Transfer Characteristics

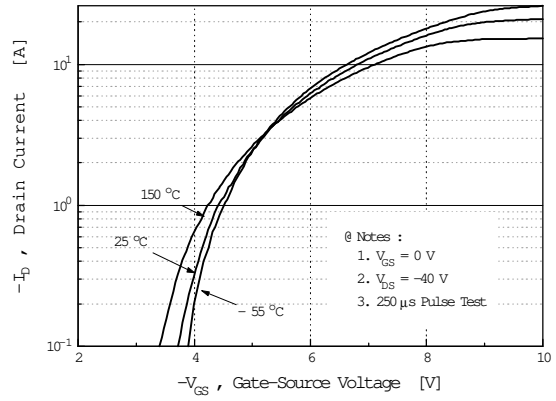


Fig 3. On-Resistance vs. Drain Current

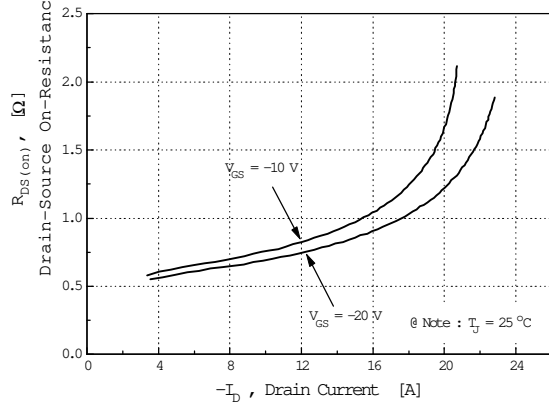


Fig 4. Source-Drain Diode Forward Voltage

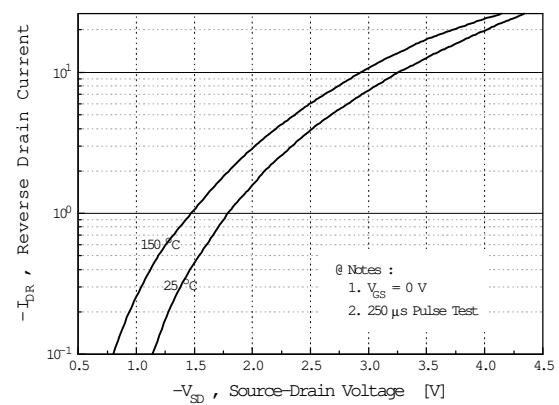


Fig 5. Capacitance vs. Drain-Source Voltage

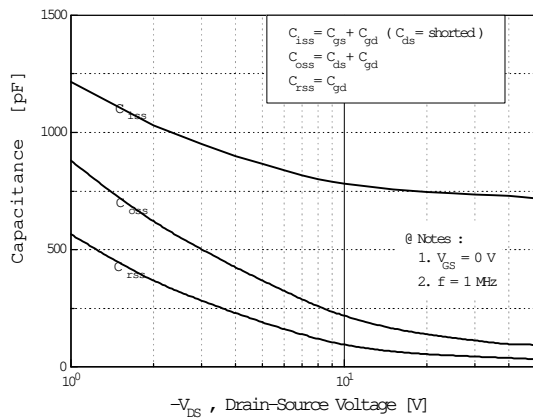
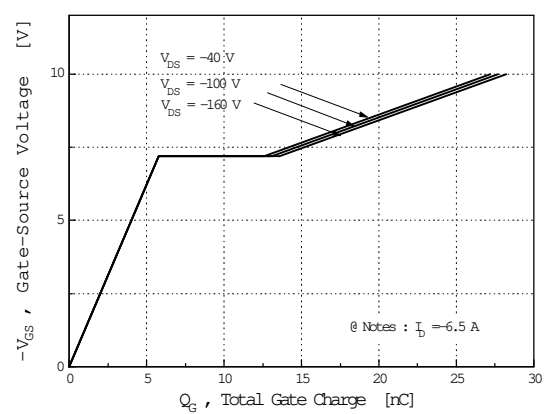
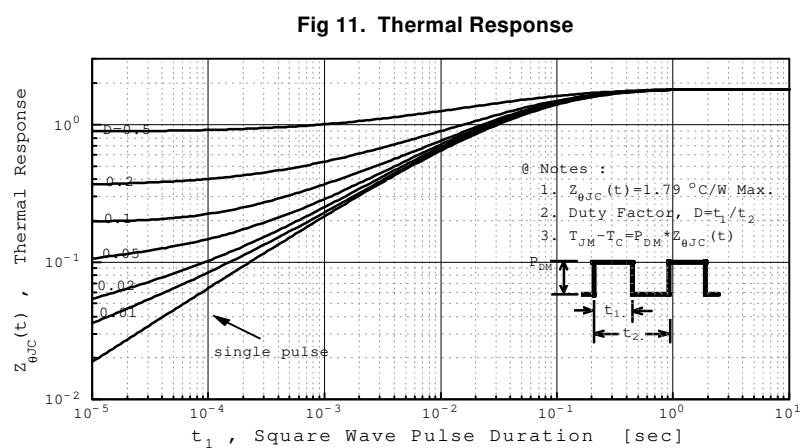
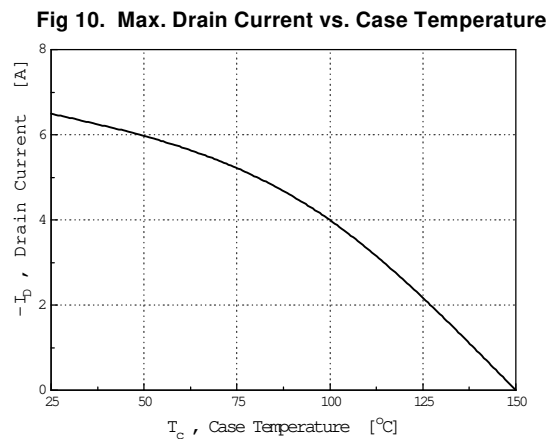
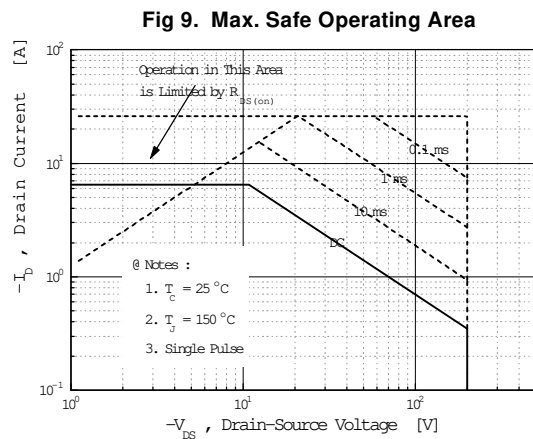
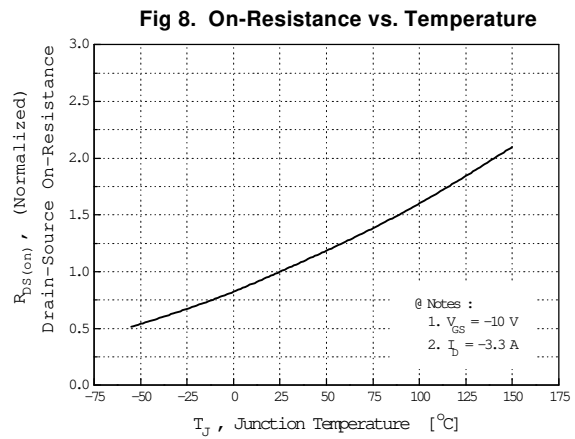
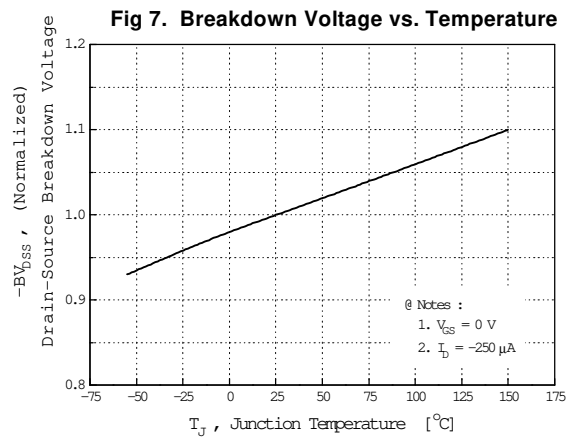
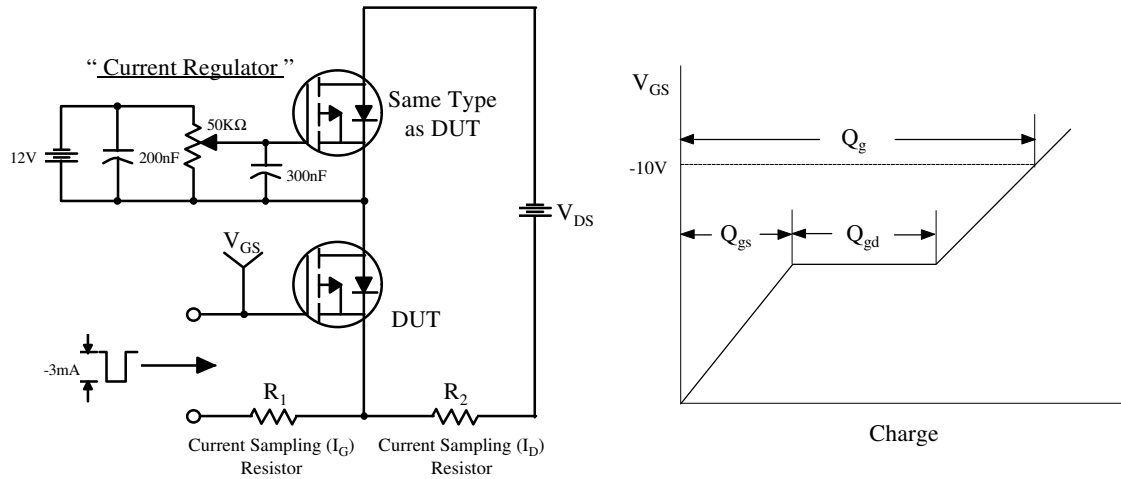


Fig 6. Gate Charge vs. Gate-Source Voltage

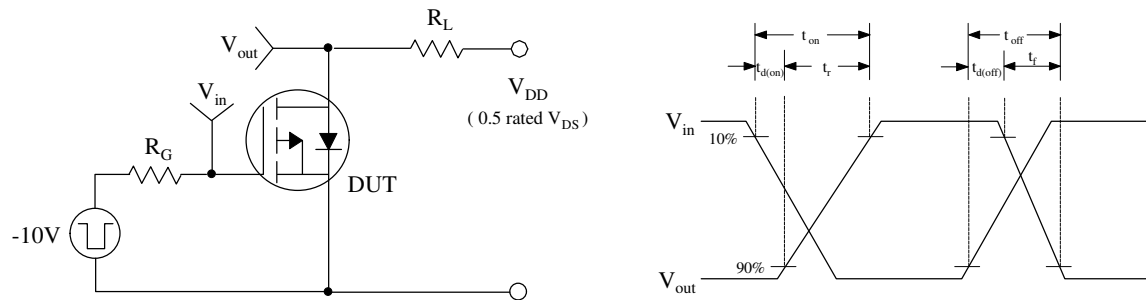




**Fig 12. Gate Charge Test Circuit & Waveform**



**Fig 13. Resistive Switching Test Circuit & Waveforms**



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

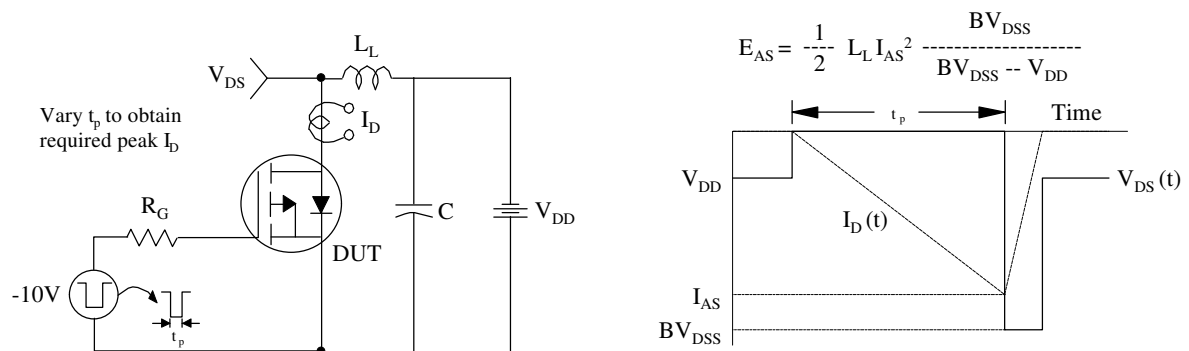
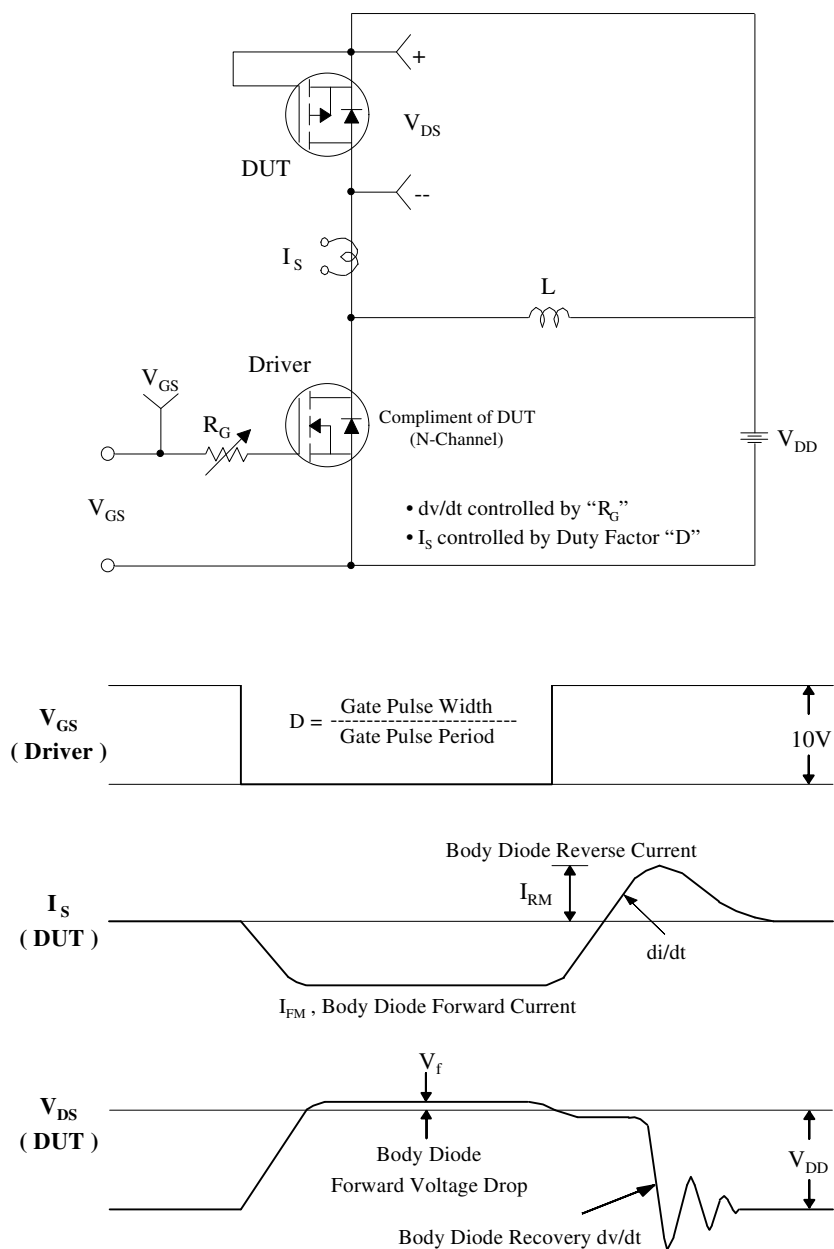


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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